## Complete 16-Bit Imaging Signal Processor

## AD9826

## FEATURES

## 16-Bit 15 MSPS A/D Converter

3-Channel 16-Bit Operation up to 15 MSPS
1-Channel 16-Bit Operation up to 12.5 MSPS
2-Channel Mode for Mono Sensors with Odd/Even Outputs
Correlated Double Sampling
1~6× Programmable Gain
$\pm 300 \mathrm{mV}$ Programmable Offset
Input Clamp Circuitry
Internal Voltage Reference
Multiplexed Byte-Wide Output
Optional Single Byte Output Mode
3-Wire Serial Digital Interface
3 V/5 V Digital I/O Compatibility
28-Lead SSOP Package
Low Power CMOS: 400 mW (Typ)
Power-Down Mode Available

## APPLICATIONS

Flatbed Document Scanners
Digital Copier
Multifunction Peripherals
Infrared Imaging Applications
Machine Vision

## PRODUCT DESCRIPTION

The AD 9826 is a complete analog signal processor for imaging applications. It features a 3-channel architecture designed to sample and condition the outputs of trilinear color CCD arrays. Each channel consists of an input clamp, C orrelated D ouble Sampler (CDS), offset DAC, and Programmable Gain Amplifier (PGA), multiplexed to a high-performance 16-bit A/D converter.
The AD 9826 can operate at speeds greater than 15 M SPS with reduced performance.
The CDS amplifiers may be disabled for use with sensors that do not require CDS, such as C ontact Image Sensors (CIS), CM OS active pixel sensors, and Focal Plane Arrays.
The 16-bit digital output is multiplexed into an 8-bit output word, which is accessed using two read cycles. There is an optional single byte output mode. The internal registers are programmed through a 3-wire serial interface, and provide adjustment of the gain, offset, and operating mode.
The AD 9826 operates from a single 5 V power supply, typically consumes 400 mW of power, and is packaged in a 28 -lead SSOP.

FUNCTIONAL BLOCK DIAGRAM


REV. A

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| Parameter | Min | Typ | Max | Unit |
| :---: | :---: | :---: | :---: | :---: |
| maximum conversion rate <br> 3-C hannel M ode with CDS <br> 2-C hannel M ode with CDS <br> 1-C hannel M ode with CDS |  | $\begin{aligned} & 30 \\ & 30 \\ & 18 \end{aligned}$ |  | $\begin{aligned} & \text { M SPS } \\ & \text { M SPS } \\ & \text { M SPS } \end{aligned}$ |
| ACCURACY (ENTIRE SIGNAL PATH) <br> ADC Resolution Integral N onlinearity (INL) <br> Differential N onlinearity (DNL) <br> No M issing Codes |  | $\begin{aligned} & 16 \\ & \pm 16 \\ & \pm 0.5 \\ & \text { Iaranteed } \end{aligned}$ |  | $\begin{aligned} & \text { Bits } \\ & \text { LSB } \\ & \text { LSB } \end{aligned}$ |
| ANALOG INPUTS Input Signal Range (Programmable) ${ }^{1}$ Allowable Reset T ransient ${ }^{1}$ Input Limits ${ }^{2}$ Input C apacitance Input Bias Current | AVSS | $\begin{aligned} & 2.0 / 4.0 \\ & 1.0 \\ & 10 \\ & 10 \end{aligned}$ | AVDD +0.3 | $\begin{aligned} & \text { V p-p } \\ & V \\ & V \\ & \text { pF } \\ & n A \end{aligned}$ |
| AM PLIFIERS <br> PGA Gain <br> PGA Gain Resolution ${ }^{2}$ <br> PGA Gain M onotonicity <br> Programmable Offset <br> Programmable Offset Resolution <br> Programmable Offset M onotonicity | 1 $-300$ | 64 ranteed <br> 512 <br> ranteed | $\begin{aligned} & 6 \\ & +300 \end{aligned}$ | V $N$ <br> Steps <br> mV <br> Steps |
| NOISE AND CROSSTALK <br> Total Output N oise @ PGA M inimum T otal Output Noise @ PGA M aximum Channel-to-C hannel Crosstalk <br> @ 15 M SPS <br> @ 6 MSPS |  | $\begin{aligned} & 3.0 \\ & 9.0 \\ & 70 \\ & 90 \end{aligned}$ |  | $\begin{aligned} & \text { LSB rms } \\ & \text { LSB rms } \\ & \text { dB } \\ & \text { dB } \end{aligned}$ |
| POWER SUPPLY REJECTION AVDD $=5 \mathrm{~V} \pm 0.25 \mathrm{~V}$ |  | 0.1 |  | \% FSR |
| DIFFERENTIAL VREF (at $25^{\circ} \mathrm{C}$ ) CAPT-CAPB |  | 2.0 |  | V |
| TEMPERATURE RANGE O perating Storage | $\begin{aligned} & -40 \\ & -65 \end{aligned}$ |  | $\begin{aligned} & +85 \\ & +150 \end{aligned}$ | $\begin{aligned} & { }^{\circ} \mathrm{C} \\ & { }^{\circ} \mathrm{C} \end{aligned}$ |
| POWER SUPPLIES AVDD DRVDD | $\begin{aligned} & 4.75 \\ & 3.0 \end{aligned}$ | $\begin{aligned} & 5.0 \\ & 5.0 \end{aligned}$ | $\begin{aligned} & 5.25 \\ & 5.25 \end{aligned}$ | $\begin{aligned} & \text { V } \\ & \text { V } \end{aligned}$ |
| OPERATING CURRENT <br> AVDD <br> DRVDD <br> Power-D own M ode |  | $\begin{aligned} & 75 \\ & 5 \\ & 200 \\ & \hline \end{aligned}$ |  | $\begin{aligned} & \mathrm{mA} \\ & \mathrm{~mA} \\ & \mu \mathrm{~A} \end{aligned}$ |
| POWER DISSIPATION <br> 3-C hannel M ode <br> 1-C hannel M ode |  | $\begin{aligned} & 400 \\ & 300 \\ & \hline \end{aligned}$ |  | $\begin{aligned} & \mathrm{mW} \\ & \mathrm{~mW} \end{aligned}$ |

NOTES
${ }^{1}$ Linear Input Signal Range is from 0 V to 4 V when the CCD 's reference level is clamped to 4 V by the AD 9826 's input clamp.

${ }^{2}$ The PG A G ain is approximately "linear in dB " and follows the equation: $G$ ain $=\frac{6.0}{1+5.0\left[\frac{63-G}{63}\right]}$ where $G$ is the register value.
Specifications subject to change without notice.

## 

| Parameter | Symbol | Min | Typ | Max | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: |
| LOGIC INPUTS High Level Input Voltage Low Level Input Voltage High Level Input C urrent Low Level Input Current Input Capacitance | $\begin{aligned} & V_{1 H} \\ & V_{I L} \\ & I_{I H} \\ & I_{I L} \\ & C_{I N} \end{aligned}$ | 2.0 | $\begin{aligned} & 10 \\ & 10 \\ & 10 \end{aligned}$ | 0.8 | $\begin{aligned} & V \\ & V \\ & \mu \mathrm{~A} \\ & \mu \mathrm{~A} \\ & \mathrm{pF} \end{aligned}$ |
| LOGIC OUTPUTS High Level Output Voltage Low Level Output Voltage High Level Output C urrent Low Level Output Current | $V_{\text {OH }}$ <br> $V_{\text {OL }}$ <br> І <br> loL | 4.5 | $\begin{aligned} & 50 \\ & 50 \end{aligned}$ | 0.1 | $\begin{aligned} & \mathrm{V} \\ & \mathrm{~V} \\ & \mu \mathrm{~A} \end{aligned}$ $\mu \mathrm{A}$ $\mu \mathrm{A}$ |
| LOGIC OUTPUTS (with DRVDD $=3 \mathrm{~V}$ ) High Level Output Voltage, ( $\mathrm{I}_{\mathrm{OH}}=50 \mu \mathrm{~A}$ ) Low Level Output Voltage ( $\mathrm{I}_{0 \mathrm{~L}}=50 \mu \mathrm{~A}$ ) | $\begin{aligned} & V_{\text {OH }} \\ & V_{\text {OL }} \end{aligned}$ | 2.95 |  | 0.05 | $\begin{aligned} & \text { V } \\ & \text { V } \end{aligned}$ |

Specifications subject to change without notice.

## TIMING SPECIFICATIONS ( $\mathrm{T}_{\text {MIN }}$ to $\mathrm{T}_{\text {MAX }}$ AVDD $=5 \mathrm{~V}$, DRVDD $=5 \mathrm{~V}$, specs are for 16 -bit performance.)

| Parameter | Symbol | Min | Typ | Max | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: |
| CLOCK PARAMETERS <br> 3-Channel Pixel Rate 1-Channel Pixel Rate ADCCLK Pulsewidth CDSCLK 1 Pulsewidth CDSCLK 2 Pulsewidth CDSCLK 1 Falling to CDSCLK 2 Rising ADCCLK Falling to CDSCLK 2 Rising CDSCLK 2 Rising to ADCCLK Rising CDSCLK 2 Falling to ADCCLK Falling CDSCLK 2 Falling to CDSCLK 1 Rising A perture Delay for CDS Clocks | $t_{\text {PRA }}$ <br> $t_{\text {prb }}$ <br> $t_{\text {ADCLK }}$ <br> $\mathrm{t}_{\mathrm{C} 1}$ <br> $\mathrm{t}_{\mathrm{C} 2}$ <br> $\mathrm{t}_{\mathrm{C} 1 \mathrm{C} 2}$ <br> $\mathrm{t}_{\mathrm{ADC2}}$ <br> $\mathrm{t}_{\mathrm{C} 2 \mathrm{ADR}}$ <br> $\mathrm{t}_{\mathrm{C} 2 \mathrm{ADF}}$ <br> $\mathrm{t}_{\mathrm{C2C1}}$ <br> $t_{A D}$ | $\begin{aligned} & 200 \\ & 80 \\ & 30 \\ & 8 \\ & 8 \\ & 0 \\ & 0 \\ & 5 \\ & 30 \\ & 5 \end{aligned}$ | 2 |  | $\begin{aligned} & \mathrm{ns} \\ & \mathrm{~ns} \\ & \mathrm{~ns} \\ & \mathrm{~ns} \\ & \mathrm{~ns} \\ & \mathrm{~ns} \\ & \mathrm{~ns} \\ & \mathrm{~ns} \\ & \mathrm{~ns} \\ & \mathrm{~ns} \\ & \mathrm{~ns} \end{aligned}$ |
| SERIALINTERFACE M aximum SCLK Frequency SLOAD to SCLK Set-Up Time SCLK to SLOAD Hold Time SDATA to SCLK Rising Set-Up Time SCLK Rising to SDATA Hold Time SCLK Falling to SDATA Valid | $\begin{aligned} & \mathrm{f}_{\mathrm{SCLK}} \\ & \mathrm{t}_{\mathrm{LS}} \\ & \mathrm{t}_{\mathrm{LH}} \\ & \mathrm{t}_{\mathrm{DS}} \\ & \mathrm{t}_{\mathrm{DH}} \\ & \mathrm{t}_{\mathrm{RDV}} \end{aligned}$ | $\begin{aligned} & 10 \\ & 10 \\ & 10 \\ & 10 \\ & 10 \\ & 10 \end{aligned}$ |  |  | $\begin{aligned} & \text { M Hz } \\ & \text { ns } \\ & \text { ns } \\ & \text { ns } \\ & \text { ns } \\ & \text { ns } \end{aligned}$ |
| DATA OUTPUTS Output Delay 3-State to Data Valid Output Enable High to 3-State L atency (Pipeline D elay) | $\begin{aligned} & \mathrm{t}_{\mathrm{OD}} \\ & \mathrm{t}_{\mathrm{DV}} \\ & \mathrm{t}_{\mathrm{Hz}} \end{aligned}$ |  | $\begin{aligned} & 6 \\ & 10 \\ & 10 \\ & 3 \text { (Fixed) } \\ & \hline \end{aligned}$ |  | ns <br> ns <br> ns Cycles |

[^1]ABSOLUTE MAXIMUM RATINGS*

| Parameter | With <br> Respect <br> To | Min | Max | Unit |
| :--- | :--- | :--- | :--- | :--- |
| VIN, CAPT, CAPB | AVSS | -0.3 | AVDD +0.3 | V |
| Digital Inputs | AVSS | -0.3 | AVDD +0.3 | V |
| AVDD | AVSS | -0.5 | +6.5 | V |
| DRVD D | DRVSS | -0.5 | +6.5 | V |
| AVSS | DRVSS | -0.3 | +0.3 | V |
| Digital O utputs | DRVSS | -0.3 | DRVDD +0.3 | V |
| Junction Temperature |  |  | 150 | ${ }^{\circ} \mathrm{C}$ |
| Storage T emperature |  | -65 | +150 | ${ }^{\circ} \mathrm{C}$ |
| Lead Temperature <br> (10 sec) |  |  | 300 | ${ }^{\circ} \mathrm{C}$ |

*Stresses above those listed under Absolute $M$ aximum Ratings may cause permanent damage to the device. This is a stress rating only; functional operation of the device at these or any other conditions above those listed in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

ORDERING GUIDE

| Model | Temperature <br> Range | Package <br> Description | Package <br> Option |
| :--- | :--- | :--- | :--- |
| AD 9826 KRS | $-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ | 5.3 mm SSOP | RS-28 |

THERMAL CHARACTERISTICS

## Thermal Resistance

$28-$ Lead 5.3 mm SSOP

$$
\begin{aligned}
& \theta_{\mathrm{JA}}=109^{\circ} \mathrm{C} / \mathrm{W} \\
& \theta_{\mathrm{JC}}=39^{\circ} \mathrm{C} / \mathrm{W}
\end{aligned}
$$

## CAUTION

ESD (electrostatic discharge) sensitive device. Electrostatic charges as high as 4000 V readily accumulate on the human body and test equipment and can discharge without detection. Although the AD 9826 features proprietary E SD protection circuitry, permanent damage may occur on devices subjected to high-energy electrostatic discharges. Therefore, proper ESD precautions are recommended to avoid performance degradation or loss of functionality.

## PIN CONFIGURATION



PIN FUNCTION DESCRIPTIONS

| Pin No. | Mnemonic | Type | Description |
| :---: | :---: | :---: | :---: |
| 1 | CDSCLK 1 | DI | CDS Reference Level Sampling Clock |
| 2 | CDSCLK 2 | DI | CDS D ata Level Sampling Clock |
| 3 | ADCCLK | DI | A/D C onverter Sampling Clock |
| 4 | OEB | DI | Output Enable, Active Low |
| 5 | DRVDD | P | Digital Output D river Supply |
| 6 | DRVSS | P | Digital Output Driver Ground |
| 7 | D 7 | DO | D ata Output M SB. ADC DB15 High Byte, ADC DB7 Low Byte |
| 8 | D6 | DO | D ata Output. ADC DB14 High Byte, ADC DB6 Low Byte |
| 9 | D 5 | DO | D ata Output. ADC D B13 High Byte, ADC DB5 Low Byte |
| 10 | D 4 | DO | D ata Output. ADC D B12 High Byte, ADC DB4 Low Byte |
| 11 | D 3 | DO | D ata Output. ADC D B11 High Byte, ADC DB3 Low Byte |
| 12 | D2 | D0 | D ata Output. ADC D B10 High Byte, ADC D B2 Low Byte |
| 13 | D 1 | DO | D ata Output. ADC D 89 High Byte, ADC DB1 Low Byte |
| 14 | D 0 | DO | D ata Output LSB. ADC D B8 High Byte, ADC DB0 Low Byte |
| 15 | SDATA | DI/DO | Serial Interface D ata Input/O utput |
| 16 | SCLK | DI | Serial Interface Clock Input |
| 17 | SLOAD | DI | Serial Interface L oad Pulse |
| 18, 28 | AVDD | P | 5 V A nalog Supply |
| 19, 27 | AVSS | P | Analog Ground |
| 20 | CAPB | AO | ADC Bottom Reference V oltage D ecoupling |
| 21 | CAPT | AO | ADC Top Reference Voltage D ecoupling |
| 22 | VINB | AI | Analog Input, Blue Channel |
| 23 | CML | AO | Internal Bias Level Decoupling |
| 24 | VING | AI | Analog Input, G reen Channel |
| 25 | OFFSET | AO | Clamp Bias Level D ecoupling |
| 26 | VINR | AI | Analog Input, Red Channel |

TYPE: AI =Analog Input, AO = Analog Output, DI = Digital Input, DO = Digital Output, $\mathrm{P}=\mathrm{P}$ ower.

## DEFINITIONS OF SPECIFICATIONS <br> INTEGRAL NONLINEARITY (INL)

Integral nonlinearity error refers to the deviation of each individual code from a line drawn from "zero scale" through "positive full scale." The point used as "zero scale" occurs $1 / 2$ LSB before the first code transition. "Positive full scale" is defined as a level $11 / 2$ LSB beyond the last code transition. The deviation is measured from the middle of each particular code to the true straight line.

## DIFFERENTIAL NONLINEARITY (DNL)

An ideal ADC exhibits code transitions that are exactly 1 LSB apart. DNL is the deviation from this ideal value. Thus every code must have a finite width. No missing codes guaranteed to 16 -bit resolution indicates that all 65536 codes, respectively, must be present over all operating ranges.

## OFFSET ERROR

The first ADC code transition should occur at a level $1 / 2$ LSB above the nominal zero scale voltage. The offset error is the deviation of the actual first code transition level from the ideal level.

## GAIN ERROR

The last code transition should occur for an analog value $11 / 2$ LSB below the nominal full scale voltage. Gain error is the deviation of the actual difference between first and last code transitions and the ideal difference between the first and last code transitions.

## INPUT REFERRED NOISE

The rms output noise is measured using histogram techniques. The ADC output codes' standard deviation is calculated in LSB, and can be converted to an equivalent voltage, using the relationship $1 \mathrm{LSB}=4 \mathrm{~V} / 65536=61 \mu \mathrm{~V}$. The noise may then be referred to the input of the AD 9826 by dividing by the PGA gain.

## CHANNEL-TO-CHANNEL CROSSTALK

In an ideal 3 -channel system, the signal in one channel will not influence the signal level of another channel. The channel-tochannel crosstalk specification is a measure of the change that occurs in one channel as the other two channels are varied. In the AD 9826, one channel is grounded and the other two channels are exercised with full scale input signals. The change in the output codes from the first channel is measured and compared with the result when all three channels are grounded. The difference is the channel-to-channel crosstalk, stated in LSB.

## APERTURE DELAY

The aperture delay is the time delay that occurs from when a sampling edge is applied to the AD 9826 until the actual sample of the input signal is held. Both CDSCLK 1 and CDSCLK 2 sample the input signal during the transition from high to low, so the aperture delay is measured from each clock's falling edge to the instant the actual internal sample is taken.

## POWER SUPPLY REJECTION

Power supply rejection specifies the maximum full-scale change that occurs from the initial value when the supplies are varied over the specified limits.


TPC 1. Typical INL Performance at 15 MSPS


TPC 2. Typical DNL Performance at 15 MSPS


TPC 3. Output Noise vs. Gain


TPC 4. Typical INL Performance at 30 MSPS


TPC 5. Typical DNL Performance at 30 MSPS


TPC 6. Input Referred Noise vs. Gain

TIMING DIAGRAMS


Figure 1. 3-Channel CDS Mode Timing
It is recommended that CDSCLK falling edges do not occur within the first 10 ns following an ADCCLK edge.


NOTE
IN 1-CHANNEL CDS MODE, THE CDSCLK1 FALLING EDGE ANDTHE CDSCLK2 RISING EDGE MUST OCCUR WHILE ADCCLK IS "LOW."
Figure 2. 1-Channel CDS Mode Timing


Figure 3. 2-Channel CDS Mode Timing


Figure 4. 2-Channel SHA Mode Timing


Figure 5. 3-Channel SHA Mode Timing


Figure 6. 1-Channel SHA Mode Timing


Figure 7. Digital Output Data Timing


Figure 8. Single Byte Mode Digital Output Data Timing


Figure 9. Serial Write Operation Timing


Figure 10. Serial Read Operation Timing


NOTES
1.THE MUX STATE MACHINE IS INTERNALLY RESET AT THE CDSCLK2 RISING EDGE.
2. EACH PIXEL IS SAMPLED AND AMPLIFIED BYTHE PGAs AT CDSCLK2 FALLING EDGE.
3. AFTER CDSCLK2 RISING EDGE,THE NEXT ADCCLK RISING EDGE WILL ALWAYS SELECT RED PGA OUTPUT.
4. THE ADC SAMPLES THE MUX OUTPUT ON ADCCLK FALLING EDGES.
5. THE MUX SWITCHESTO THE NEXT PGA OUTPUT AT ADCCLK RISING EDGES.

Figure 11. Internal Timing Diagram for 3-Channel CDS Mode

## FUNCTIONAL DESCRIPTION

The AD 9826 can be operated in six different modes: 3-C hannel CDS M ode, 3-Channel SHA M ode, 2-C hannel CDS M ode, 2-C hannel SHA M ode, 1-Channel CDS M ode, and 1-C hannel SH A M ode. Each mode is selected by programming the C onfiguration Registers through the serial interface. For more detail on CDS or SHA mode operation, see the C ircuit O peration section.

## 3-Channel CDS Mode

In 3-C hannel CDS M ode, the AD 9826 simultaneously samples the Red, Green, and Blue input voltages from the CCD outputs. The sampling points for each C orrelated D ouble Sampler (CDS) are controlled by CDSCLK 1 and CDSCLK 2 (see Figures 11 and 13). CDSCLK 1's falling edge samples the reference level of the CCD waveform. CDSCLK 2's falling edge samples the data level of the CCD waveform. Each CDS amplifier outputs the difference between the CCD's reference and data levels. $N$ ext, the output voltage of each CDS amplifier is level-shifted by an Offset DAC. The voltages are then scaled by the three Programmable $G$ ain Amplifiers before being multiplexed through the 16 -Bit ADC. The ADC sequentially samples the PGA outputs on the falling edges of ADCCLK.
The offset and gain values for the Red, Green, and Blue channels are programmed using the serial interface. The order in which the channels are switched through the multiplexer is selected by programming the M UX C onfiguration register.
Timing for this mode is shown in Figure 1. It is recommended that the falling edge of CDSCLK 2 occur before the rising edge of ADCCLK, although this is not required to satisfy the minimum timing constraints. The rising edge of CDSCLK 2 should not occur before the previous falling edge of ADCCLK, as shown by $\mathrm{t}_{\text {ADC2 }}$. T he output data latency is three clock cycles.

## 3-Channel SHA Mode

In 3-C hannel SH A M ode, the AD 9826 simultaneously samples the Red, Green, and Blue input voltages. The sampling point is controlled by CDSCLK 2. CDSCLK2's falling edge samples the input waveforms on each channel. The output voltages from the three SH As are modified by the offset DAC s and then scaled by the three PGAs. The outputs of the PGAs are then multiplexed through the 16 -bit ADC. The ADC sequentially samples the PGA outputs on the falling edges of ADCCLK.
The input signal is sampled with respect to the voltage applied to the OFFSET pin (see Figure 14). With the OFFSET pin grounded, a zero volt input corresponds to the ADC's zero scale output. The OFFSET pin may also be used as a coarse offset adjust pin. A voltage applied to this pin will be subtracted from the voltages applied to the Red, Green, and Blue inputs in the first amplifier stage of the AD 9826. The input clamp is disabled in this mode. For more information, see the C ircuit O peration section.
Timing for this mode is shown in Figure 5. CDSCLK 1 should be grounded in this mode. Although it is not required, it is recommended that the falling edge of CDSCLK 2 occur before the rising edge of ADCCLK. The rising edge of CDSCLK 2 should not occur before the previous falling edge of ADCCLK, as shown by $\mathrm{t}_{\mathrm{ADC2}}$. T he output data latency is three ADCCLK cycles.
The offset and gain values for the Red, Green, and Blue channels are programmed using the serial interface. The order in which the channels are switched through the multiplexer is selected by programming the M UX C onfiguration register.

## 2-Channel CDS Mode

The 2 - C hannel M ode is selected by writing a " 1 " into two of the channel select bits of the M UX register (D 4-D 6). Bit D5 of the configuration register also needs to be set low to take the part out of 3 -Channel $M$ ode. The channels that will be used is determined by the contents of Bits D4-D 6 of the M UX C onfiguration Register (see Table III). The combination of inputs that can be selected are; RG, RB, or GB by writing a " 1 " into the appropriate bit. The sample order is selected by Bit D7. If D7 is high, the M UX will sample in the following order: RG or RB or GB depending on which channels are turned on. If Bit D7 is set low the mux will sample in the following order: GR or BR or BG depending on which channels are turned on.
The AD 9826 simultaneously samples the selected channels' input voltages from the CCD outputs. The sampling points for each C orrelated D ouble Sampler (CDS) are controlled by CDSCLK 1 and CDSCLK 2 (see Figure 11). CDSCLK 1's falling edge samples the reference level of the CCD waveform. CDSCLK 2's falling edge samples the data level of the CCD waveform. Each CDS amplifier outputs the difference between the CCD 's reference and data levels. Next, the output voltage of each CDS amplifier is level-shifted by an Offset DAC. The voltages are then scaled by the two Programmable $G$ ain Amplifiers before being multiplexed through the 16 -bit ADC. TheADC sequentially samples the PGA outputs on the falling edges of ADCCLK.
The offset and gain values for the Red, Green, and Blue channels are programmed using the serial interface. The order in which the channels are switched through the multiplexer is selected by programming the M UX C onfiguration Register.
Timing for this mode is shown in Figure 3. The rising edge of CDSCLK 2 should not occur before the previous falling edge of ADCCLK, as shown by $\mathrm{t}_{\mathrm{ADC2}}$. The output data latency is three clock cycles.

## 2-Channel SHA Mode

The 2-C hannel $M$ ode is selected by writing a " 1 " into two of the channel select bits of the M UX Register (D4-D6). Bit D5 of the configuration register also needs to be set low to take the part out of 3 -C hannel M ode. The channels that will be used is determined by the contents of Bits D 4-D 6 of the M UX C onfiguration Register (see T able III). The combination of inputs that can be selected are; RG, RB, or GB by writing a " 1 " into the appropriate bit. T he sample order is selected by Bit D7. If D 7 is high, the mux will sample in the following order: RG or RB or GB, depending on which channels are turned on. If Bit D7 is set low, the mux will sample in the following order: GR or BR or BG, depending on which channels are turned on.
In 2-C hannel SH A M ode, the AD 9826 simultaneously samples the selected channels' input voltages. The sampling point is controlled by CDSCLK 2. CDSCLK 2's falling edge samples the input waveforms on each channel. The output voltages from the two SHAs are modified by the offset DACs and then scaled by the two PGAs. The outputs of the PGAs are then multiplexed through the 16 -bit ADC. The ADC sequentially samples the PGA outputs on the falling edges of ADCCLK.
The input signal is sampled with respect to the voltage applied to the OFFSET pin (see Figure 14). With the OFFSET pin grounded, a zero volt input corresponds to the ADC's zero scale output. The OFFSET pin may also be used as a coarse offset

## AD9826

adjust pin. A voltage applied to this pin will be subtracted from the voltages applied to the Red, Green, and Blue inputs in the first amplifier stage of the AD 9826. The input clamp is disabled in this mode. F or more information, see the Circuit O peration section.
Timing for this mode is shown in Figure 4. CDSCLK 1 should be grounded in this mode. The rising edge of CDSCLK 2 should not occur before the previous falling edge of ADCCLK, as shown by $t_{A D C 2}$. The output data latency is three ADCCLK cycles. The offset and gain values for the Red, Green, and Blue channels are programmed using the serial interface. The order in which the channels are switched through the multiplexer is selected by programming the MUX Configuration Register.

## 1-Channel CDS Mode

This mode operates the same way as the $3-C$ hannel CDS mode. The difference is that the multiplexer remains fixed in this mode, so only the channel specified in the M UX C onfiguration Register is processed.
Timing for this mode is shown in Figure 2.

## 1-Channel SHA Mode

This mode operates the same way as 3-C hannel SHA mode, except that the multiplexer remains stationary. Only the channel specified in the MUX C onfiguration Register is processed.
Timing for this mode is shown in Figure 6. CDSCLK 1 should be grounded in this mode of operation.

## Configuration Register

The C onfiguration Register controls the AD 9826's operating mode and bias levels. Bits D 8 and D 1 should always be set low.

Bit D 7 controls the input range of the AD 9826. Setting D 7 high sets the input range to 4 V while setting Bit D 7 low sets the input range to 2 V . Bit D 6 controls the internal voltage reference. If the AD 9826's internal voltage reference is used, then this bit is set high. Setting Bit D 6 low will disable the internal voltage reference, allowing an external voltage reference to be used. Setting Bit D 5 high will configure the AD 9826 for 3channel operation. If $D 5$ is set low, the part will be in either 2 CH or 1 CH mode based on the settings in the M UX C onfiguration Register (See T able III and the M UX Configuration R egister description). Setting Bit D 4 high will enable the CDS mode of operation, and setting this bit low will enable the SHA mode of operation. Bit D3 sets the dc bias level of the AD 9826's input clamp.
This bit should always be set high for the 4 V clamp bias, unless a CCD with a reset feedthrough transient exceeding 2 V is used. If the 3 V clamp bias level is used, then the peak-to-peak input signal range to the AD 9826 is reduced to 3 V maximum. Bit D2 controls the power-down mode. Setting Bit D 2 high will place the AD 9826 into a very low-power "sleep" mode. All register contents are retained while the AD 9826 is in the powered-down state. Bit D 0 controls the output mode of the AD 9826. Setting Bit D 0 high will enable a single byte output mode where only the 8 M SBs of the 16 b ADC will be output on each rising edge of ADCCLK (see Figure 8). If Bit D0 is set low, then the 16 b ADC output is multiplexed into two bytes. The M SByte is output on ADCCLK rising edge and the LSByte is output on ADCCLK falling edge.

Table I. Internal Register Map

| Register Name | Address |  |  | Data Bits |  |  |  |  |  |  |  |  |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  | A2 | A1 | A0 | D8 | D7 | D6 | D5 | D4 | D3 | D2 | D1 | D0 |
| Configuration | 0 | 0 | 0 | 0 | Input Rng | VREF | 3CH M ode | CDS On | Clamp | Pwr Dn | 0 | 1 Byte Out |
| M U X C onfig | 0 | 0 | 1 | 0 | RGB/BGR | Red | G reen | Blue | 0 | 0 | 0 | 0 |
| Red PGA | 0 | 1 | 0 | 0 | 0 | 0 | M SB |  |  |  |  | LSB |
| Green PGA | 0 | 1 | 1 | 0 | 0 | 0 | M SB |  |  |  |  | LSB |
| Blue PGA | 1 | 0 | 0 | 0 | 0 | 0 | M SB |  |  |  |  | LSB |
| Red Offset | 1 | 0 | 1 | M SB |  |  |  |  |  |  |  | LSB |
| G reen Offset | 1 | 1 | 0 | M SB |  |  |  |  |  |  |  | LSB |
| Blue Offset | 1 | 1 | 1 | M SB |  |  |  |  |  |  |  | LSB |

Table II. Configuration Register Settings

| D8 | D7 | D6 | D5 | D4 | D3 | D2 | D1 | D0 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| Set | Input Range | Internal VREF | 3CH M ode | CDS Operation | Input Clamp Bias | Power-D own | $\begin{aligned} & \text { Set } \\ & \text { to } \\ & 0 \end{aligned}$ | Output M ode |
| $0$ | $\begin{aligned} & 1=4 \mathrm{~V} * \\ & 0=2 \mathrm{~V} \end{aligned}$ | $\begin{aligned} & 1=\text { E nabled* } \\ & 0=\text { D isabled } \end{aligned}$ | $\begin{aligned} & 1=0 n^{*} \\ & 0=0 \mathrm{ff} \end{aligned}$ | $\begin{aligned} & 1=\text { CDS M ode* } \\ & 0=\text { SHA M ode } \end{aligned}$ | $\begin{aligned} & 1=4 \mathrm{~V} * \\ & 0=3 \mathrm{~V} \end{aligned}$ | $\begin{aligned} & 1=0 n \\ & 0=O \text { ff }(\mathrm{N} \text { ormal })^{*} \end{aligned}$ |  | $\begin{aligned} & 0=2 \text { Byte* } \\ & 1=1 \text { Byte } \end{aligned}$ |

[^2]
## MUX Configuration Register

The M U X C onfiguration Register controls the sampling channel order and the 2-Channel M ode configuration in the AD 9826. Bits D 8 and D 3-D 0 should always be set low. Bit D 7 is used when operating in 3-C hannel or 2-C hannel M ode. Setting Bit D 7 high will sequence the $M U X$ to sample the Red channel first, then the Green channel, and then the Blue channel. When in 3-channel mode, the CD SCLK 2 pulse always resets the M U X to sample the Red channel first (see Figure 11). When Bit D 7 is set low, the channel order is reversed to Blue first, G reen second, and Red third. The CDSCLK 2 pulse will always reset the M UX to sample the Blue channel first. Bits D 6, D 5, and D4 are used when operating in 1 or $2-C$ hannel $M$ ode. Bit $D 6$ is set high to sample the Red channel. Bit D 5 is set high to sample the G reen channel. Bit D 4 is set high to sample the Blue channel. The M UX will remain stationary during 1-channel mode. T woChannel M ode is selected by setting two of the channel select Bits (D 4-D6) high. The M UX samples the channels in the order selected by Bit D 7 .

## PGA Gain Registers

There are three PGA registers for individually programming the gain in the Red, Green, and Blue channels. Bits D 8, D 7, and D 6 in each register must be set low, and Bits D 5 through D 0 control the gain range from $1 \times$ to $6 \times$ in 64 increments. See Figure 17 for a graph of the PGA gain versus PG A register code. The coding for the PGA registers is straight binary, with an all "zeros" word corresponding to the minimum gain setting ( $1 \times$ ) and an all "ones" word corresponding to the maximum gain setting ( $6 \times$ ).
Offset Registers
There are three $O$ ffset Registers for individually programming the offset in the Red, Green, and Blue channels. Bits D 8 through D 0 control the offset range from -300 mV to +300 mV in 512 increments. The coding for the Offset Registers is Sign M agnitude, with D 8 as the sign bit. T able V shows the offset range as a function of the Bits D 8 through D 0 .

Table III. MUX Configuration Register Settings

| D8 | D7 | D6 | D5 | D4 | D3 | D2 | D1 | DO |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| Set | M UX Order | Channel Select | C hannel Select | C hannel Select | $\begin{aligned} & \text { Set } \\ & \text { to } \\ & 0 \end{aligned}$ | $\begin{aligned} & \text { Set } \\ & \text { to } \\ & 0 \end{aligned}$ | $\begin{aligned} & \text { Set } \\ & \text { to } \\ & 0 \end{aligned}$ | $\begin{aligned} & \text { Set } \\ & \text { to } \\ & 0 \end{aligned}$ |
| $\begin{aligned} & \text { to } \\ & 0 \end{aligned}$ | $\begin{aligned} & 1=R-G-B^{*} \\ & 0=B-G-R \end{aligned}$ | $\begin{aligned} & 1=\text { RED } \\ & 0=0 \mathrm{ff} \end{aligned}$ | $\begin{aligned} & 1=\text { GREEN } \\ & 0=0 \text { ff* } \end{aligned}$ | $\begin{aligned} & 1=\text { BLUE } \\ & 0=0 \mathrm{ff} * \end{aligned}$ |  |  |  |  |

Table IV. PGA Gain Register Settings

*Power-on default value.
Table V. Offset Register Settings

| D8 | D7 | D6 | D5 | D4 | D3 | D2 | D1 | D0 | Offset (mV) |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| M SB |  |  |  |  |  |  |  | LSB |  |
| 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0* | 0 |
| 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 1 | $+1.2$ |
| 0 | 1 | 1 | 1 | 1 | 1 | 1 | 1 | 1 | +300 |
| 1 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | $0$ |  |
| 1 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 1 | $-1.2$ |
| 1 | 1 | 1 | 1 | 1 | 1 | 1 | 1 | 1 | -300 |

*Power-on default value.

## AD9826

## CIRCUIT OPERATION

## Analog Inputs-CDS Mode Operation

Figure 12 shows the analog input configuration for the CDS mode of operation. Figure 13 shows the internal timing for the sampling switches. The CCD reference level is sampled when CDSCLK 1 transitions from high to low, opening S1. The CCD data level is sampled when C D SCL K 2 transitions from high to low, opening S2. S3 is then closed, generating a differential output voltage representing the difference between the two sampled levels.
The input clamp is controlled by CDSCLK 1. When CDSCLK 1 is high, S 4 closes and the internal bias voltage is connected to the analog input. The bias voltage charges the external $0.1 \mu \mathrm{~F}$ input capacitor, level-shifting the CCD signal into the AD 9826's input common-mode range. The time constant of the input clamp is determined by the internal $5 \mathrm{k} \Omega$ resistance and the external $0.1 \mu \mathrm{~F}$ input capacitance.


Figure 12. CDS-Mode Input Configuration (All Three Channels Are Identical)

## External Input Coupling Capacitors

The recommended value for the input coupling capacitors is $0.1 \mu \mathrm{~F}$. While it is possible to use a smaller capacitor, this larger value is chosen for several reasons:

## Crosstalk

The input coupling capacitor creates a capacitive divider with any parasitic capacitance between PCB traces and on chip traces. $\mathrm{C}_{\text {IN }}$ should be large relative to these parasitic capacitances in order to minimize this effect. F or example, with a 100 pF input capacitance and just a few hundred fF of parasitic capacitance on the PCB and/or the IC the imaging system could expect to have hundreds of LSBs of crosstalk at the 16 b level. U sing a large capacitor value $=0.1 \mu \mathrm{~F}$ will minimize any errors due to crosstalk.

## Signal Attenuation

The input coupling capacitor creates a capacitive divider with a CM OS integrated circuit's input capacitance, attenuating the CCD signal level. $\mathrm{C}_{\text {IN }}$ should be large relative to the IC's 10 pF input capacitance in order to minimize this effect.

## Linearity

Some of the input capacitance of a CM OS IC is junction capacitance, which varies nonlinearly with applied voltage. If the input coupling capacitor is too small, then the attenuation of the CCD signal will vary nonlinearly with signal level. T his will degrade the system linearity performance.

## Sampling Errors

The internal 4 pF sample capacitors have a "memory" of the previously sampled pixel. There is a charge redistribution error between $\mathrm{C}_{\text {IN }}$ and the internal sample capacitors for larger pixel-to-pixel voltage swings. As the value of $C_{I N}$ is reduced, the resulting error in the sampled voltage will increase. With a $\mathrm{C}_{\text {IN }}$ value of $0.1 \mu \mathrm{~F}$, the charge redistribution error will be less than 1 LSB for a full-scale pixel-to-pixel voltage swing.


Figure 13. CDS-Mode Internal Switch Timing

## Analog Inputs-SHA Mode Operation

Figure 14 shows the analog input configuration for the SH A mode of operation. Figure 15 shows the internal timing for the sampling switches. The input signal is sampled when CD SCL K 2 transitions from high to low, opening S1. The voltage on the OFFSET pin is also sampled on the falling edge of CDSCLK2, when S2 opens. S3 is then closed, generating a differential output voltage representing the difference between the sampled input voltage and the OFFSET voltage. The input clamp is disabled during SHA mode operation.


Figure 14. SHA-Mode Input Configuration (All Three Channels Are Identical)


Figure 15. SHA-Mode Internal Switch Timing

Figure 16 shows how the OFFSET pin may be used in a CIS application for coarse offset adjustment. M any CIS signals have dc offsets ranging from several hundred millivolts to more than 1 V . By connecting the appropriate dc voltage to the OFF SET pin, the CIS signal will be restored to "zero." After the large dc offset is removed, the signal can be scaled using the PGA to maximize the ADC's dynamic range.


Figure 16. SHA-Mode Used with External DC Offset

## AD9826

## Programmable Gain Amplifiers

The AD 9826 uses one Programmable G ain Amplifier (PGA) for each channel. E ach PGA has a gain range from $1 \times(0 \mathrm{~dB})$ to $6.0 \times$ ( 15.56 dB ), adjustable in 64 steps. Figure 17 shows the PGA gain as a function of the PGA register code. Although the gain curve is approximately "linear in dB ," the gain in $\mathrm{V} / \mathrm{V}$ varies nonlinearly with register code, following the equation:

$$
\text { Gain }=\frac{6.0}{1+5.0\left[\frac{63-G}{63}\right]}
$$

where $G$ is the decimal value of the gain register contents, and varies from 0 to 63 .


## APPLICATIONS INFORMATION

## Circuit and Layout Recommendations

The recommended circuit configuration for 3-C hannel CDS M ode operation is shown in Figure 18. The recommended input coupling capacitor value is $0.1 \mu \mathrm{~F}$ (see C ircuit $O$ peration section for more details). A single ground plane is recommended for the AD 9826. A separate power supply may be used for DRVDD, the digital driver supply, but this supply pin should still be decoupled to the same ground plane as the rest of the AD 9826. The loading of the digital outputs should be minimized, either by using short traces to the digital ASIC, or by using external digital buffers. T o minimize the effect of digital transients during major output code transitions, the falling edge of CDSCLK 2 should occur coincident with or before the rising edge of AD CCLK (see Figures 1 through 6 for timing). All $0.1 \mu \mathrm{~F}$ decoupling capacitors should be located as close as possible to the AD 9826 pins. When operating in 1CH or 2CH M ode, the unused analog inputs should be grounded.

F or 3-C hannel SHA M ode, all of the above considerations also apply, except that the analog input signals are directly connected to the AD 9826 without the use of coupling capacitors. The analog input signals must already be dc-biased between 0 V and 4 V . Also, the OFFSET pin should be grounded if the inputs to the AD 9826 are to be referenced to ground, or a dc offset voltage should be applied to the OFFSET pin in the case where a coarse offset needs to be removed from the inputs. (See Figure 16 and the C ircuit Operation section for more details.)

Figure 17. PGA Gain Transfer Function


Figure 18. Recommended Circuit Configuration, 3-Channel CDS Mode

## OUTLINE DIMENSIONS

Dimensions shown in inches and (mm).

## 28-Lead 5.3 mm SSOP

(RS-28)


## Revision History

Location PageData Sheet changed from REV. Oto REV. A.
Edits to ORDERING GUIDE ..... 4
Edits to Figure 2 ..... 8
Edits to Figure 6 ..... 10


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[^1]:    NOTES
    It is recommended that CDSCLK falling edges do not occur within the first 10 ns following an ADCCLK edge.
    Specifications subject to change without notice.

[^2]:    *Power-on default value

